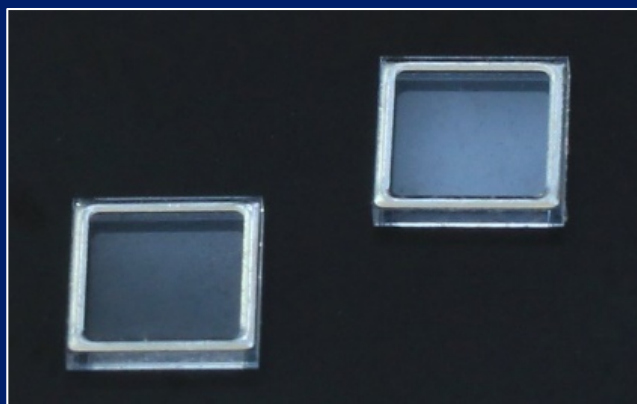


# Glass lid with AGC Solder for Hermetic seal PKG



**AGC Inc.**

**Development & Planning Div.  
Advanced Materials Division  
Electronics Materials General  
Division  
Electronics Company**

## <Features>

### 1. Hetero-materials can be bonded

AGC Solder can bond between heterogeneous materials because of **lower Young's modulus** compared to other major solders.

### 2. Sealable in OXYGEN atmosphere

Because of having **excellent oxidation resistant**. Oxygen sealed in PKG effective to **improve lifetime of UV-LED**※

※ Influence of the LED heterostructure and chip package on the lifetime of high power UV-B and UV-C LEDs., Photonics west 2016, 9748-59, Session12

### 3. Low temperature sealing

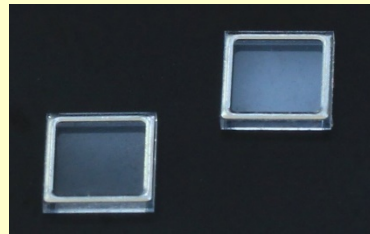
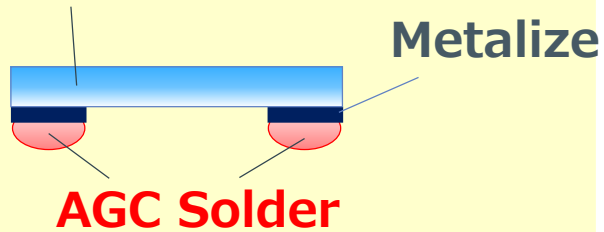
Having lower temperature melting point than Au-Sn solder, which is the **advantage of prevention of re-melting** of already-bonded parts **without risk of hermetic break** even if post reflow process.

# Overview: Glass LID with AGC Solder for hermetic seal PKG

<AGC>

**Glass LID**

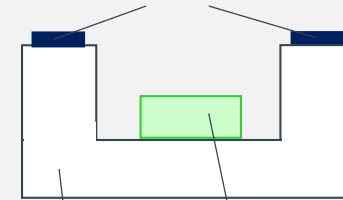
Silica, Borosilicate, etc.



**Ready to seal**

<Customer>

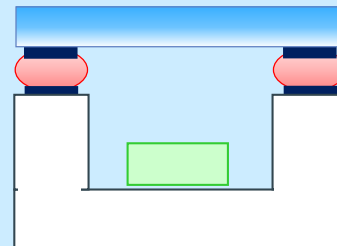
**Metalize**



**Solid state chip**  
LED, LD, etc.

**Ceramics cavity**

**Customer to bond**  
**LED chip to cavity**



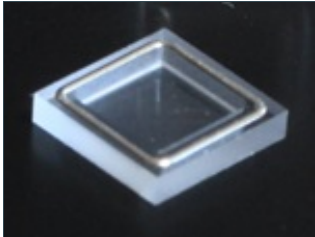
**Hermetic sealing to**  
**make PKG in air**  
**(oxygen atmosphere),**  
**around 280°C**

# Overview: Various shape of Glass LID with AGC Solder

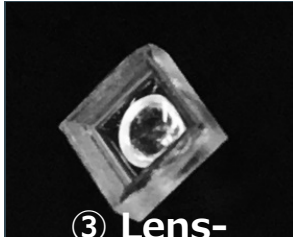
## 1. Various shape LID



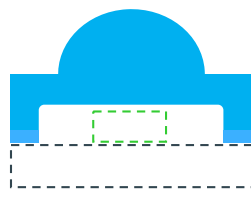
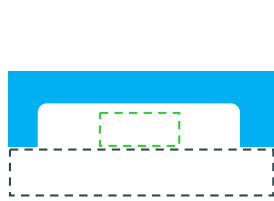
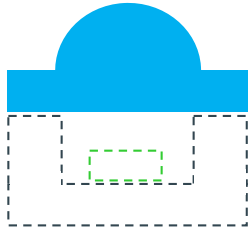
① Lens LID



② Cavity LID



③ Lens-Cavity LID

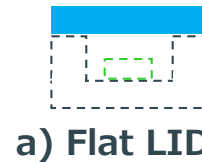
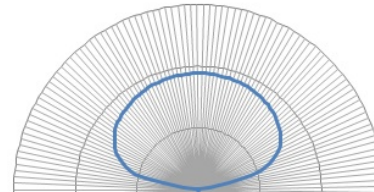


① : Lens LID make **design flexibility** of equipment increase

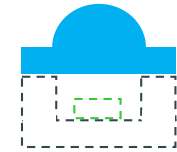
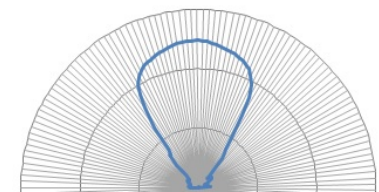
② : Cavity LID make **assemble cost reduced** because it can **use ceramic plate** for chip bonding

③ : ① + ②

## 2. Very precise lens shape control



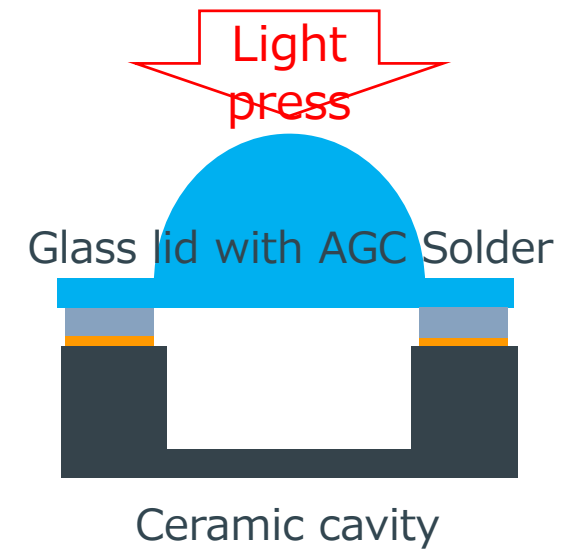
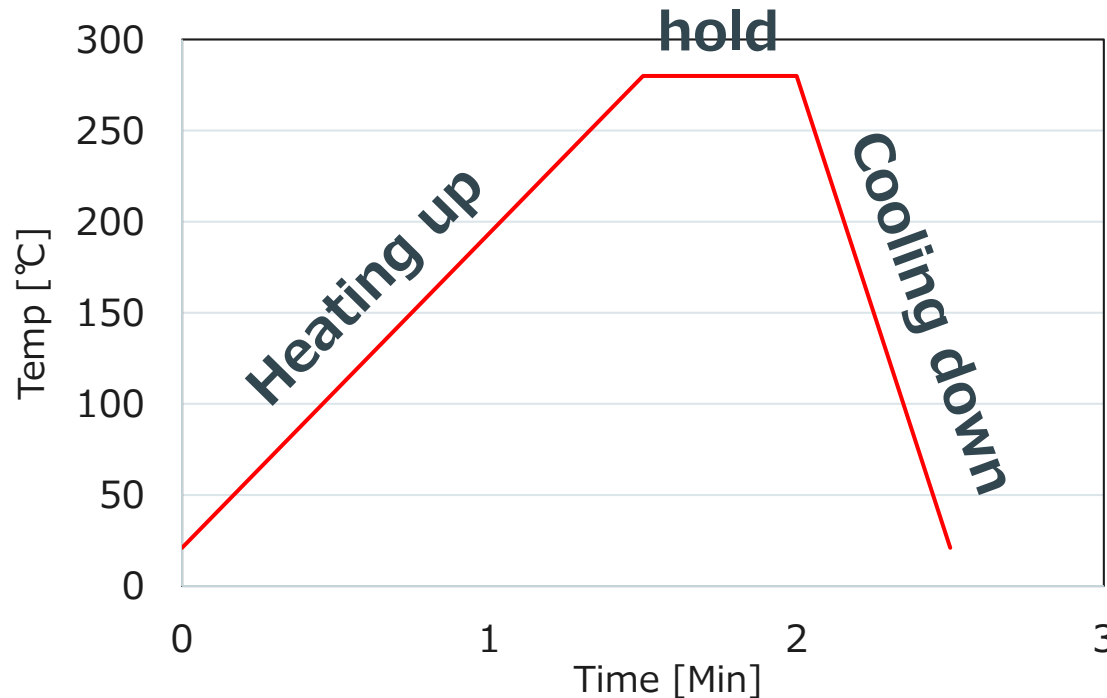
a) Flat LID



b) Lens LID

**Neither stray light nor asymmetric light distribution.**

# Recommendation of bonding condition



	Heating up	hold	Cooling down
Time [Min]	~1.5	1~2	2~2.5
Temp [°C]	R.T.→280	280	280→R.T.
Press [g]		10 or more	

※ Depending on the ceramics cavity spec or the customer's post-bonding process condition, it may be better to adjust this recommendation. Please feel free to contact us.

**Sealing of the package is completed simply by pressing glass lid and heating the AGC Solder.**

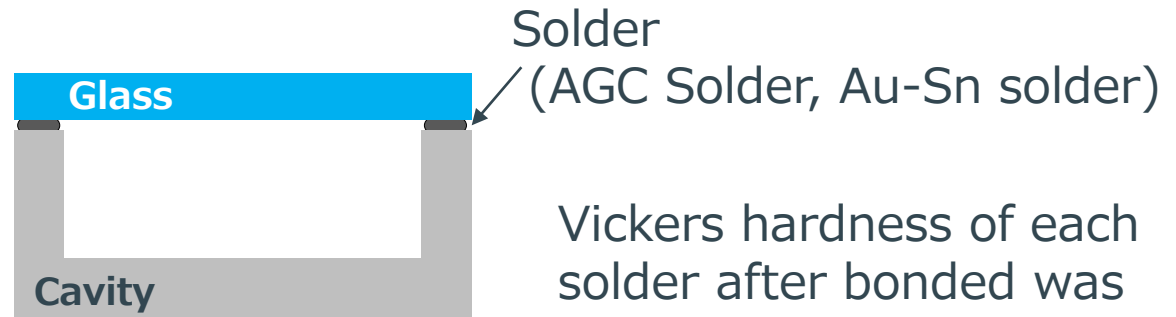
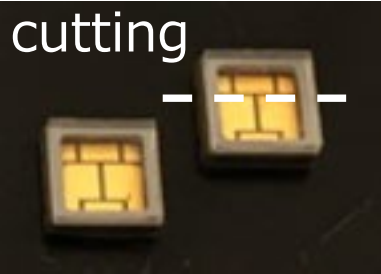
# Material properties / characteristics

Physical property	AGC Solder (Sn-Ni-X)	Au-20Sn	Memo
Melting point (°C)	<b>230</b>	280	
Density (g*cm <sup>-3</sup> )	<b>7.3</b>	14.5	
Young's modulus* (GPa)	<b>20</b>	57	Slope of Strain-Stress line
Vickers Hardness (HV0.002)	<b>85</b>	252	Measured after bonded
Thickness of surface oxide layer after heating up in air for bonding (nm)	<b>5</b>	23	Heating up to bonding temperature: AGC Solder (280°C) Au-Sn solder (320°C)

※ Slope of Stress-Strain line

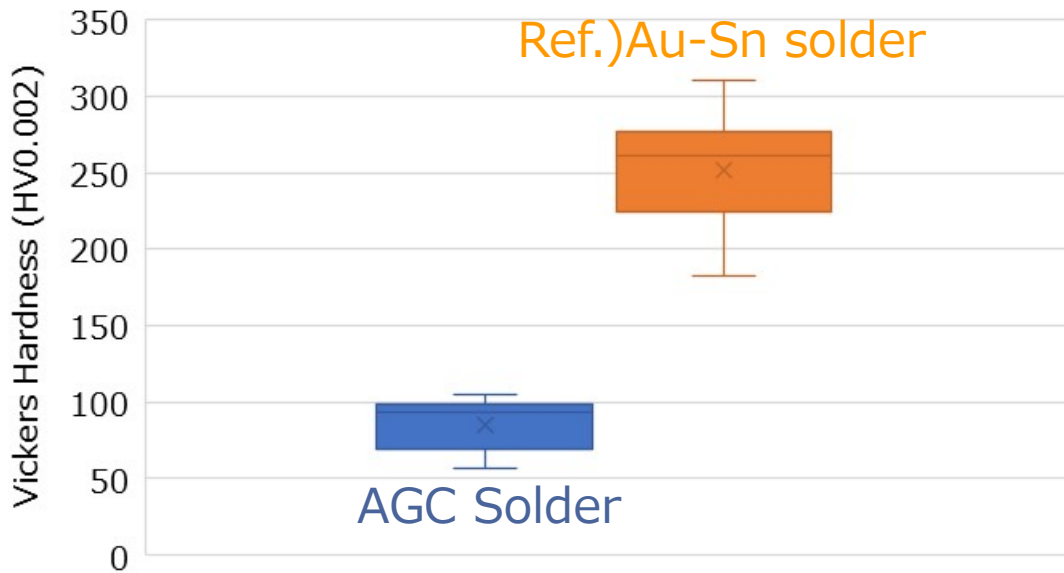
# Hardness of Solder after bonded

3.5mm-sq.PKG



Vickers hardness of each solder after bonded was measured.

## ■ Vickers hardness after bonded



Hardness of AGC Solder is extremely low.

It means AGC Solder shows that it retains flexibility to reduce stress after bonded.

## ■ Helium leak test result after sealing

Measuring method : Bombing method

Measurement condition :

Measured within 1 hour after applying 5.1 bar of He for 2 hours

**Result : Helium leak rate  $4.9 \times 10^{-10}$  Pa\*m<sup>3</sup>/s or less**

## ■ Helium leak test result after reflow heat resistance test

Reflow condition: Heated at 260 °C for 40 seconds 5 times

Measurement condition :

Measured within 1 hour after applying 5.1 bar of He for 2 hours

**Result : Helium leak rate  $4.9 \times 10^{-10}$  Pa\*m<sup>3</sup>/s or less**

**AGC Solder has enough resistance to reflow at 260 °C**



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